

# N-Channel 200 V (D-S) MOSFET

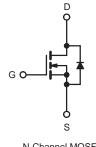
PRODUCT SUMMA	RY	
V <sub>DS</sub> (V)	200	)
R <sub>DS(on)</sub> (Ω)	$V_{GS} = 10 V$	0.058
Q <sub>g</sub> (Max.) (nC)	64	
Q <sub>gs</sub> (nC)	12	
Q <sub>gd</sub> (nC)	30	
Configuration	Sing	le

#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- Surface Mount
- Low-Profile Through-Hole
- Available in Tape and Reel
  Dynamic dV/dt Rating
- 150 °C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Compliant to RoHS Directive 2002/95/EC







N-Channel N	<b>IOSFET</b>
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ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub> :	= 25 °C, unless otherwi	se noted)		
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-Source Voltage		V <sub>DS</sub>	200	V
Gate-Source Voltage		V <sub>GS</sub>	± 20	v
Continuous Drain Current	$V_{GS}$ at 10 V $T_C = 25 \degree C$ $T_C = 100 \degree C$	la la	20	
Continuous Drain Ourrent	$T_{\rm C} = 100 ^{\circ}{\rm C}$	I I <sub>D</sub>	14	A
Pulsed Drain Current <sup>a, e</sup>	I <sub>DM</sub>	72		
Linear Derating Factor			1.0	W/°C
Single Pulse Avalanche Energy <sup>b, e</sup>		E <sub>AS</sub>	580	mJ
Avalanche Current <sup>a</sup>		I <sub>AR</sub>	20	A
Repetiitive Avalanche Energy <sup>a</sup>		E <sub>AR</sub>	13	mJ
Maximum Power Dissipation	T <sub>C</sub> = 25 °C	Р	42	w
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	гD	P <sub>D</sub> 13	
Peak Diode Recovery dV/dt <sup>c, e</sup>	dV/dt	5.0	V/ns	
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s		300 <sup>d</sup>	1 0

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

- b.  $V_{DD}$  = 50 V, starting T<sub>J</sub> = 25 °C, L = 2.7 mH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> = 18 A (see fig. 12).
- c.  $I_{SD} \le 20$  A,  $dI/dt \le 150$  A/µs,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150$  °C.

d. 1.6 mm from case.



THERMAL RESISTANCE RAT	INGS			
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient (PCB Mounted, Steady-State) <sup>a</sup>	R <sub>thJA</sub>	-	40	°C/W
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	1.0	

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static				•	•		
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> =	= 0 V, I <sub>D</sub> = 250 μA	200	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference	e to 25 °C, I <sub>D</sub> = 1 mA <sup>c</sup>	-	0.29	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 250 μΑ	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	,	V <sub>GS</sub> = ± 20 V	-	-	± 100	nA
Zava Cata Valtaga Duain Cuurant		V <sub>DS</sub> =	= 200 V, V <sub>GS</sub> = 0 V	-	-	25	μΑ
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = 160 V	∕, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	250	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 V$	I <sub>D</sub> = 11 A <sup>b</sup>	-	0.065	-	Ω
Forward Transconductance	<b>g</b> fs	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 11 A <sup>d</sup>		6.7	-	-	S
Dynamic		·					
Input Capacitance	C <sub>iss</sub>		$\label{eq:VGS} \begin{array}{l} V_{GS} = 0 \ V, \\ V_{DS} = 25 \ V, \\ f = 1.0 \ \text{MHz}, \ \text{see fig. } 5^d \end{array}$		1300	-	pF
Output Capacitance	C <sub>oss</sub>				430	-	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.			130	-	
Total Gate Charge	Qg		I <sub>D</sub> = 20 A, V <sub>DS</sub> = 160 V, see fig. 6 and 13 <sup>b, c</sup>	-	-	70	nC
Gate-Source Charge	$Q_gs$	$V_{GS} = 10 V$		-	-	13	
Gate-Drain Charge	Q <sub>gd</sub>		-	-	39	1	
Turn-On Delay Time	t <sub>d(on)</sub>			-	14	-	- ns
Rise Time	t <sub>r</sub>	Vaa -	V <sub>DD</sub> = 100 V, I <sub>D</sub> = 20 A,		51	-	
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_{g} = 9.1 \ \Omega, R_{D} = 5.4 \ \Omega, \text{ see fig. } 10^{\text{b}, \text{ c}}$		-	45	-	
Fall Time	t <sub>f</sub>			-	36	-	
Drain-Source Body Diode Characteristic	s	·					
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	20	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	72	
Body Diode Voltage	$V_{SD}$	$T_J = 25 \text{ °C}, I_S = 20 \text{ A}, V_{GS} = 0 \text{ V}^{b}$		-	-	2.0	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	- $T_J = 25 \text{ °C}, I_F = 20 \text{ A}, dI/dt = 100 \text{ A}/\mu \text{s}^{\text{b, c}}$		-	300	610	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	3.4	7.1	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	-on is doi	ninated b	y L <sub>S</sub> and	L <sub>D</sub> )	

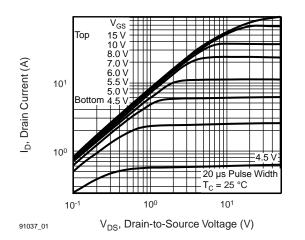
#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.

c. Uses IRF640/SiHF640 data and test conditions.





## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



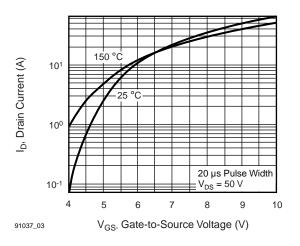


Fig. 3 - Typical Transfer Characteristics

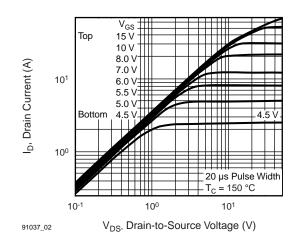


Fig. 2 - Typical Output Characteristics, T<sub>J</sub> = 175 °C

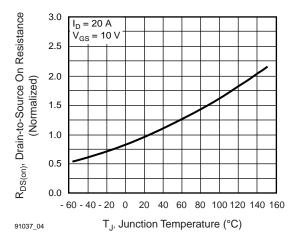


Fig. 4 - Normalized On-Resistance vs. Temperature



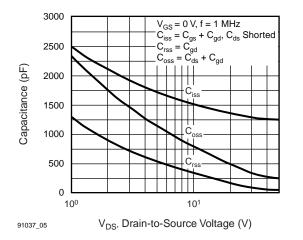


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

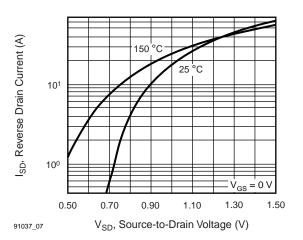


Fig. 7 - Typical Source-Drain Diode Forward Voltage

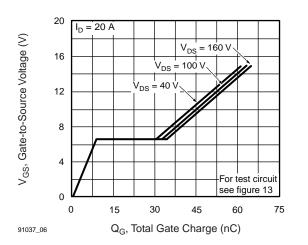


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

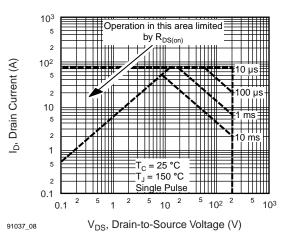


Fig. 8 - Maximum Safe Operating Area



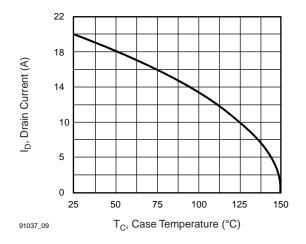


Fig. 9 - Maximum Drain Current vs. Case Temperature

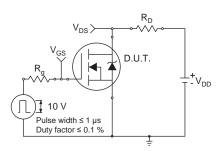


Fig. 10a - Switching Time Test Circuit

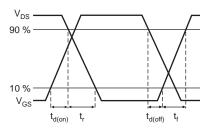


Fig. 10b - Switching Time Waveforms

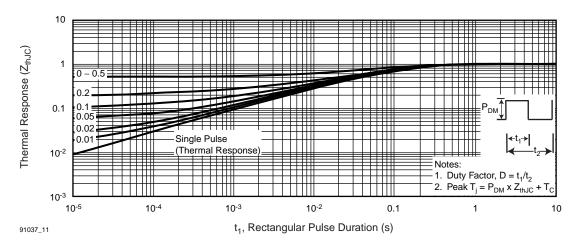


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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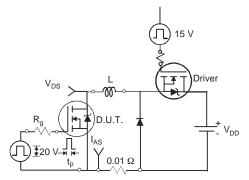


Fig. 12a - Unclamped Inductive Test Circuit

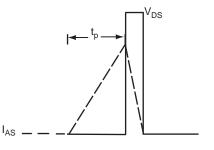


Fig. 12b - Unclamped Inductive Waveforms

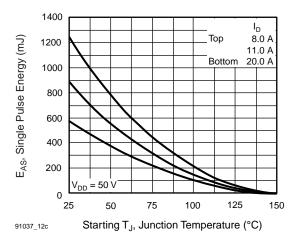


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

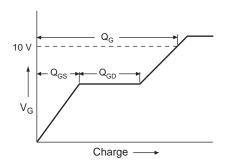


Fig. 13a - Basic Gate Charge Waveform

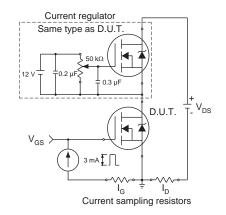
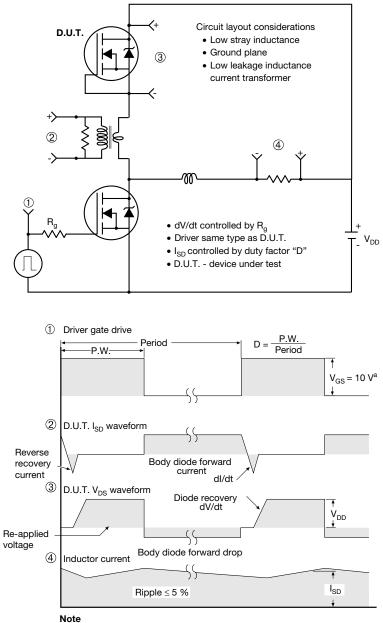


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

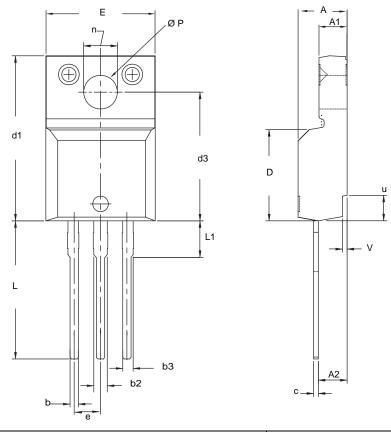


a.  $V_{GS}$  = 5 V for logic level devices

Fig. 14 - For N-Channel



### **TO-220 FULLPAK (HIGH VOLTAGE)**



DIM.	MILLIN	METERS	INCHES		
	MIN.	MAX.	MIN.	MAX.	
А	4.570	4.830	0.180	0.190	
A1	2.570	2.830	0.101	0.111	
A2	2.510	2.850	0.099	0.112	
b	0.622	0.890	0.024	0.035	
b2	1.229	1.400	0.048	0.055	
b3	1.229	1.400	0.048	0.055	
С	0.440	0.629	0.017	0.025	
D	8.650	9.800	0.341	0.386	
d1	15.88	16.120	0.622	0.635	
d3	12.300	12.920	0.484	0.509	
E	10.360	10.630	0.408	0.419	
е	2.54	BSC	0.100 BSC		
L	13.200	13.730	0.520	0.541	
L1	3.100	3.500	0.122	0.138	
n	6.050	6.150	0.238	0.242	
ØP	3.050	3.450	0.120	0.136	
u	2.400	2.500	0.094	0.098	
V	0.400	0.500	0.016	0.020	

Notes

1. To be used only for process drawing. 2. These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads. 3. All critical dimensions should C meet  $C_{pk} > 1.33$ . 4. All dimensions include burrs and plating thickness. 5. No chipping or package damage.

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